

## CBTD3253 <br> Dual 1-of-4 FET multiplexer/demultiplexer with level shifting

Preliminary data

PHILIPS

## FEATURES

- $5 \Omega$ switch connection between two ports
- TTL-compatible input levels
- Designed to be used in level shifting applications
- Minimal propagation delay through the switch
- ESD protection exceeds 2000 V HBM per JESD22-A114, 200 V MM per JESD22-A115 and 1000 V CDM per JESD22-C101
- Latch-up testing is done to JESDEC Standard JESD78 which exceeds 100 mA


## DESCRIPTION

The CBTD3253 is a dual 1 -of-4 high-speed TTL-compatible FET multiplexer/demultiplexer. The low on resistance of the switch allows inputs to be connected to outputs without adding propagation delay or generating additional ground bounce noise.
$1 \overline{O E}, 2 \overline{O E}, S 0$, and $S 1$ select the appropriate $B$ output for the A-input data.

Internal diode allows voltage level shifting from 5 V inputs to 3.3 V outputs.

The CBTD3253 is characterized for operation from -40 to $+85^{\circ} \mathrm{C}$.

## PIN CONFIGURATION

| い $\square^{16}$ |  |
| :---: | :---: |
| S1 2 | 15 |
| $184 \sqrt{3}$ |  |
| 1834 | 13 2B4 |
| $1 \mathrm{B2} 5$ | $12 \mathrm{2B3}$ |
| $1 \mathrm{B1} 6$ | 11 2B2 |
| 14.7 | 10 2B1 |
| GND 8 | 9 2A |
|  | S00574 |

## PIN DESCRIPTION

| PIN NUMBER | SYMBOL | NAME AND FUNCTION |
| :---: | :---: | :--- |
| 1 | $1 \overline{\mathrm{OE}}$ | Output enable |
| 2 | S 1 | Select-control input |
| $3,4,5,6$ | $1 \mathrm{~B}[1-4]$ | B outputs |
| 7 | 1 A | A input |
| 8 | GND | Ground $(0 \mathrm{~V})$ |
| 9 | 2 A | A input |
| $10,11,12,13$ | $2 \mathrm{~B}[1-4]$ | Select-control input |
| 14 | S 0 | Select-control input |
| 15 | $2 \overline{\mathrm{OE}}$ | Output enable |
| 16 | $\mathrm{~V}_{\mathrm{CC}}$ | Positive supply voltage |

## ORDERING INFORMATION

| PACKAGES | TEMPERATURE RANGE | ORDER CODE | TOPSIDE MARK | DWG NUMBER |
| :--- | :---: | :---: | :---: | :---: |
| 16-pin plastic SOIC | -40 to $85^{\circ} \mathrm{C}$ | CBTD3253D | CBTD3253 | SOT109-1 |
| 16 -pin plastic SSOP | -40 to $85^{\circ} \mathrm{C}$ | CBTD3253DB | CD3253 | SOT338-1 |
| 16-pin plastic SSOP (QSOP) | -40 to $85^{\circ} \mathrm{C}$ | CBTD3253DS | CBD3253 | SOT519-1 |
| 16 -pin plastic TSSOP | -40 to $85^{\circ} \mathrm{C}$ | CBTD3253PW | CBD3253 | SOT403-1 |

Standard packing quantities and other packaging data is available at www.philipslogic.com/packaging.

Dual 1-of-4 FET multiplexer/demultiplexer with level shifting

## LOGIC DIAGRAM (positive logic)



FUNCTION TABLE

| INPUTS |  |  |  | FUNCTION |
| :---: | :---: | :---: | :---: | :---: |
| OE1 | OE2 | S1 | S0 |  |
| H | X | X | X | Disconnect 1A |
| X | H | X | X | Disconnect 2A |
| L | L | L | L | 1A to 1B1 and 2A to 2B1 |
| L | L | L | H | 1A to 1B2 and 2A to 2B2 |
| L | L | H | L | 1A to 1B3 and 2A to 2B3 |
| L | L | H | H | 1A to 1B4 and 2A to 2B4 |

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## ABSOLUTE MAXIMUM RATINGS ${ }^{1}$

| SYMBOL | PARAMETER | CONDITIONS | RATING | UNIT |
| :---: | :--- | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | DC supply voltage |  | -0.5 to +7.0 | V |
| $\mathrm{~V}_{\mathrm{I}}$ | DC input voltage ${ }^{2}$ |  | -0.5 to +7.0 | V |
|  | Continuous channel current | $\mathrm{V}_{/ / \mathrm{O}}<0$ | 128 | mA |
| $\mathrm{I}_{\mathrm{K}}$ | Input clamp current |  | -50 | mA |
| $\mathrm{~T}_{\mathrm{stg}}$ | Storage temperature range | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |  |

## NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
2. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
3. The package thermal impedance is calculated in accordance with JESD 51-7.

## RECOMMENDED OPERATING CONDITIONS

| SYMBOL | PARAMETER | LIMITS |  | UNIT |
| :---: | :--- | :---: | :---: | :---: |
|  |  | MIN |  |  |
|  |  |  |  |  |
| $\mathrm{V}_{\mathrm{CC}}$ | DC supply voltage | 4.5 | 5.5 | V |
| $\mathrm{~V}_{\mathrm{IH}}$ | High-level input voltage | 2 | - | V |
| $\mathrm{V}_{\mathrm{IL}}$ | Low-level Input voltage | - | 0.8 | V |
| $\mathrm{~T}_{\text {amb }}$ | Operating free-air temperature range | -40 | +85 | ${ }^{\circ} \mathrm{C}$ |

## NOTE:

1. All unused control inputs of the device must be held at $\mathrm{V}_{\mathrm{CC}}$ or GND to ensure proper device operation.

## DC ELECTRICAL CHARACTERISTICS

| SYMBOL | PARAMETER |  | TEST CONDITIONS | LIMITS |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\mathrm{T}_{\text {amb }}=-40$ to $+85{ }^{\circ} \mathrm{C}$ |  |
|  |  |  | MIN | TYP1 | MAX |  |
| $\mathrm{V}_{\mathrm{IK}}$ | Input clamp voltage |  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} ; \mathrm{I}_{\mathrm{I}}=-18 \mathrm{~mA}$ | - | - | -1.2 | V |
| $\mathrm{V}_{\mathrm{P}}$ | Pass voltage |  |  | $\mathrm{V}_{1}=\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V} ; \mathrm{I} / \mathrm{O}=-100 \mathrm{~mA}$ | 3.4 | 3.6 | 3.9 | V |
| 1 | Input leakage current |  | $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=5.5$ or GND | - | - | $\pm 1$ | $\mu \mathrm{A}$ |
| ICC | Quiescent supply current |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V} ; \mathrm{I}_{\mathrm{O}}=0, \mathrm{~V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$ or GND | - | - | 15 | mA |
| $\Delta_{\text {CC }}$ | Control inputs ${ }^{2}$ |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, one input at 3.4 V , other inputs at $\mathrm{V}_{\mathrm{CC}}$ or GND | - | - | 1.5 | mA |
| $\mathrm{Cl}_{1}$ | Control pins |  | $\mathrm{V}_{1}=3 \mathrm{~V}$ or 0 | - | 4.5 | - | pF |
| $\mathrm{C}_{\text {IO(OFF) }}$ | Power-off leakage current | A port | $\mathrm{V}_{\mathrm{O}}=3 \mathrm{~V}$ or 0; $\overline{\mathrm{OE}}=\mathrm{V}_{\mathrm{CC}}$ | - | 23.5 | - | pF |
|  |  | B port | $\mathrm{V}_{\mathrm{O}}=3 \mathrm{~V}$ or $0 ; \overline{\mathrm{OE}}=\mathrm{V}_{\mathrm{CC}}$ | - | 6.5 | - |  |
| $\mathrm{ron}^{3}$ | On-resistance | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{V}_{1}=0 \mathrm{~V} ; \mathrm{I}_{\mathrm{I}}=64 \mathrm{~mA}$ | - | 5 | 7 | $\Omega$ |
|  |  |  | $\mathrm{V}_{\mathrm{I}}=0 \mathrm{~V} ; \mathrm{I}_{\mathrm{I}}=30 \mathrm{~mA}$ | - | 5 | 7 |  |
|  |  |  | $\mathrm{V}_{\mathrm{I}}=2.4 \mathrm{~V} ; \mathrm{I}_{\mathrm{I}}=15 \mathrm{~mA}$ | - | 16 | 50 |  |

## NOTES:

1. All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$.
2. This is the increase in supply current for each input that is at the specified TTL voltage level rather than $\mathrm{V}_{C C}$ or GND
3. Measured by the voltage drop between the $A$ and the $B$ terminals at the indicated current through the switch.

On-state resistance is determined by the lowest voltage of the two (A or B) terminals.

Dual 1-of-4 FET multiplexer/demultiplexer with level shifting

## AC CHARACTERISTICS

$\mathrm{T}_{\text {amb }}=-40$ to $+85^{\circ} \mathrm{C} ; \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$

| SYMBOL | PARAMETER | FROM (INPUT) | TO (OUTPUT) | LIMITS |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | $\mathrm{V}_{\mathrm{CC}}=+5.0 \mathrm{~V} \pm 0.5 \mathrm{~V}$ |  |  |
|  |  |  |  | MIN | MAX |  |
| $t_{\text {pd }}$ | Propagation delay ${ }^{1}$ | A or B | B or A | - | 0.25 | ns |
|  |  | S | A or B | 1.6 | 11.0 |  |
| $\mathrm{t}_{\text {en }}$ | Output enable time to High and Low level | S | A or B | 1.6 | 11.0 | ns |
|  |  | OE |  | 1.6 | 11.4 |  |
| $t_{\text {dis }}$ | Output disable time from High and Low level | S | A or B | 2.2 | 8 | ns |
|  |  | OE |  | 2.0 | 7 |  |

NOTE:

1. The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

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## AC WAVEFORMS



Waveform 1. Pulse duration


Note:
Waveform 1 is for an output with internal conditions such that
the output is low except when disabled by the output control.
Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
SA00592

## Waveform 2. 3-State Output Enable and Disable Times

## NOTES:

1. $t_{P L Z}$ and $t_{\text {PHZ }}$ are the same as $t_{\text {dis }}$.
2. $t_{P Z L}$ and $t_{p z H}$ are the same as $t_{\text {en }}$.
3. $\mathrm{t}_{\mathrm{PLH}}$ and $\mathrm{t}_{\mathrm{PHL}}$ are the same as $\mathrm{t}_{\mathrm{pd}}$.

TEST CIRCUIT AND WAVEFORMS


DEFINITIONS
$C_{L}=$ Load capacitance includes jig and probe capacitance; see AC CHARACTERISTICS for value.

## NOTES:

1. All input pulses are supplied by generators having the following characteristics: $\operatorname{PRR} \leq 10 \mathrm{MHz}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, \mathrm{t}_{\mathrm{r}} \leq 2.5 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 2.5 \mathrm{~ns}$.
2. The outputs are measured one at a time with one transition per measurement.

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## TYPICAL CHARACTERISTICS



Figure 1. $\mathrm{V}_{\mathrm{OH}}$ values $\left(\mathrm{V}_{\mathrm{in}}=\mathrm{V}_{\mathrm{CC}}\right)$

Dual 1-of-4 FET multiplexer/demultiplexer with level shifting

detail X


DIMENSIONS (inch dimensions are derived from the original mm dimensions)

| UNIT | A max. | $\mathrm{A}_{1}$ | $\mathrm{A}_{2}$ | $\mathrm{A}_{3}$ | $b_{p}$ | c | $\mathrm{D}^{(1)}$ | $E^{(1)}$ | e | $\mathrm{H}_{\mathrm{E}}$ | L | $L_{p}$ | Q | v | w | y | $Z^{(1)}$ | $\theta$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| mm | 1.75 | $\begin{aligned} & 0.25 \\ & 0.10 \end{aligned}$ | $\begin{aligned} & 1.45 \\ & 1.25 \end{aligned}$ | 0.25 | $\begin{aligned} & 0.49 \\ & 0.36 \end{aligned}$ | $\begin{aligned} & 0.25 \\ & 0.19 \end{aligned}$ | $\begin{gathered} 10.0 \\ 9.8 \end{gathered}$ | $\begin{aligned} & 4.0 \\ & 3.8 \end{aligned}$ | 1.27 | $\begin{aligned} & 6.2 \\ & 5.8 \end{aligned}$ | 1.05 | $\begin{aligned} & 1.0 \\ & 0.4 \end{aligned}$ | $\begin{aligned} & 0.7 \\ & 0.6 \end{aligned}$ | 0.25 | 0.25 | 0.1 | $\begin{aligned} & 0.7 \\ & 0.3 \end{aligned}$ | $\begin{aligned} & 8^{0} \\ & 0^{\circ} \end{aligned}$ |
| inches | 0.069 | $\begin{aligned} & 0.010 \\ & 0.004 \end{aligned}$ | $\begin{aligned} & 0.057 \\ & 0.049 \end{aligned}$ | 0.01 | $\begin{aligned} & 0.019 \\ & 0.014 \end{aligned}$ | $\begin{array}{\|l\|} \hline 0.0100 \\ 0.0075 \end{array}$ | $\begin{aligned} & 0.39 \\ & 0.38 \end{aligned}$ | $\begin{aligned} & 0.16 \\ & 0.15 \end{aligned}$ | 0.050 | $\begin{aligned} & 0.244 \\ & 0.228 \end{aligned}$ | 0.041 | $\begin{aligned} & 0.039 \\ & 0.016 \end{aligned}$ | $\begin{aligned} & 0.028 \\ & 0.020 \end{aligned}$ | 0.01 | 0.01 | 0.004 | $\begin{aligned} & 0.028 \\ & 0.012 \end{aligned}$ |  |

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

| OUTLINE VERSION | REFERENCES |  |  | EUROPEAN PROJECTION | ISSUE DATE |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | IEC | JEDEC | EIAJ |  |  |
| SOT109-1 | 076E07 | MS-012 |  | $\square$ - | $\begin{aligned} & -97-05-22 \\ & 99-12-27 \end{aligned}$ |

Dual 1-of-4 FET multiplexer/demultiplexer with level shifting


DIMENSIONS (mm are the original dimensions)

| UNIT | $\mathbf{A}$ <br> $\mathbf{m a x}$. | $\mathbf{A}_{\mathbf{1}}$ | $\mathbf{A}_{\mathbf{2}}$ | $\mathbf{A}_{\mathbf{3}}$ | $\mathbf{b}_{\mathbf{p}}$ | $\mathbf{c}$ | $\mathbf{D}^{(1)}$ | $\mathbf{E}^{(1)}$ | $\mathbf{e}$ | $\mathbf{H}_{\mathbf{E}}$ | $\mathbf{L}$ | $\mathbf{L}_{\mathbf{p}}$ | $\mathbf{Q}$ | $\mathbf{v}$ | $\mathbf{w}$ | $\mathbf{y}$ | $\mathbf{Z}^{(1)}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| mm | 2.0 | 0.21 | 1.80 | 0.25 | 0.38 | 0.20 | 6.4 | 5.4 | 0.6 | 7.9 | 1.25 | 1.03 | 0.9 | 0.2 | 0.13 | 0.1 | 1.00 |
|  | 0.05 | 1.65 | 0.25 | 0.09 | 6.0 | 5.2 | 0.65 | 7.6 | $8^{0}$ |  |  |  |  |  |  |  |  |

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

| OUTLINE VERSION | REFERENCES |  |  | EUROPEAN PROJECTION | ISSUE DATE |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | IEC | JEDEC | EIAJ |  |  |
| SOT338-1 |  | MO-150 |  | - (-) | $\begin{aligned} & 95-02-04 \\ & 99-12-27 \end{aligned}$ |

Dual 1-of-4 FET multiplexer/demultiplexer with level shifting


DIMENSIONS (mm are the original dimensions)

| UNIT | $\mathbf{A}$ <br> max. | $\mathbf{A}_{\mathbf{1}}$ | $\mathbf{A}_{\mathbf{2}}$ | $\mathbf{A}_{\mathbf{3}}$ | $\mathbf{b}_{\mathbf{p}}$ | $\mathbf{c}$ | $\mathbf{D}^{(1)}$ | $\mathbf{E}^{(1)}$ | $\mathbf{e}$ | $\mathbf{H}_{\mathbf{E}}$ | $\mathbf{L}$ | $\mathbf{L}_{\mathbf{p}}$ | $\mathbf{v}$ | $\mathbf{w}$ | $\mathbf{y}$ | $\mathbf{Z}^{(1)}$ | $\theta$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| mm | 1.73 | 0.25 | 1.55 | 0.25 | 0.31 | 0.25 | 5.0 | 4.0 | 0.635 | 6.2 | 1.0 | 0.89 | 0.2 | 0.18 | 0.09 | 0.18 | $8^{0}$ |
| 0.10 | 1.40 | 0.20 | 0.18 | 4.8 | 3.8 | 0.83 | 5.8 | 1.0 | 0.41 | 0.2 | $0^{0}$ |  |  |  |  |  |  |

Note

1. Plastic or metal protrusions of 0.20 mm maximum per side are not included.

| OUTLINE <br> VERSION | REFERENCES |  |  |  | EUROPEAN <br> PROJECTION | ISSUE DATE |
| :--- | :--- | :--- | :--- | :--- | :--- | :---: |
|  | IEC | JEDEC | EIAJ |  |  |  |
| SOT519-1 |  |  |  |  |  |  |

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detail X


DIMENSIONS (mm are the original dimensions)

| UNIT | $\mathbf{A}$ <br> $\mathbf{m a x}$ | $\mathbf{A}_{\mathbf{1}}$ | $\mathbf{A}_{\mathbf{2}}$ | $\mathbf{A}_{\mathbf{3}}$ | $\mathbf{b}_{\mathbf{p}}$ | $\mathbf{c}$ | $\mathbf{D}^{(1)}$ | $\mathbf{E}^{(2)}$ | $\mathbf{e}$ | $\mathbf{H}_{\mathbf{E}}$ | $\mathbf{L}$ | $\mathbf{L}_{\mathbf{p}}$ | $\mathbf{Q}$ | $\mathbf{v}$ | $\mathbf{w}$ | $\mathbf{y}$ | $\mathbf{Z}^{(1)}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| mm | 1.10 | 0.15 | 0.95 | 0.25 | 0.30 | 0.2 | 5.1 | 4.5 | 0.65 | 6.6 | 1.0 | 0.75 | 0.4 | 0.2 | 0.13 | 0.1 | 0.40 |
| 0.0 | 0.80 | 0.25 | 0.19 | 0.1 | 4.9 | 4.3 | $8^{0}$ |  |  |  |  |  |  |  |  |  |  |

Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

| OUTLINE VERSION | REFERENCES |  |  | EUROPEAN PROJECTION | ISSUE DATE |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | IEC | JEDEC | EIAJ |  |  |
| SOT403-1 |  | MO-153 |  | - ( | $\begin{aligned} & -95-04-04 \\ & 99-12-27 \end{aligned}$ |

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| Data sheet status ${ }^{[1]}$ | Product <br> status ${ }^{[2]}$ | Definitions |
| :--- | :--- | :--- |
| Objective data | Development | This data sheet contains data from the objective specification for product development. <br> Philips Semiconductors reserves the right to change the specification in any manner without notice. |
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Limiting values definition - Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.
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